	- Oxygen Sensor Monitors and Constants			
	Bank 1 Sensor 1			
	Test #	Test Description	Decimal Range	Hex Range
	03	Low Volt CAL 4 Switch Time Calc.	0 - 1.275 volts	00 - FF
	04	Hi Volt CAL 4 Switch Time Calc. Rich to Lean Sensor Switch Time	0 - 1.275 volts	00 - FF
	05 06	Lean to Rich Sensor Switch Time	0 - 1.02 seconds 0 - 1.02 seconds	00 - FF 00 - FF
	70	Rich to Lean Switches	0 - 1.02 seconds 0 - 255 switches	00 - FF
	71	Lean to Rich Switches	0 - 255 switches	00 - FF
	81	R/L Response to L/R Response Ratio	0 - 128 ratio	00 - FF
-d- ¢0¢				
de \$06				1
	Type of Test Limit			
Test ID	(see footnote on last page)	Description	Decimal Banga	Hay Dange
(hex)	and Comp ID	Description	Decimal Range	Hex Range
	(hex)			
		Catalyst Efficiency Steady State Monitor		
Test ID	Comp ID			
04	E0	Catalyst efficiency test	0 - 1024 mV	0000 - FFFF
		Exhaust Gas Recirculation System Monitor		
Test ID	Comp ID			T
07	4D	EGR flow decel test	0 - 255.996 kPa	0000 - FFFF
			<u> </u>	
***************************************		Enhanced Evaporative System Monitor #2 (.020" Leak)		***************************************
Test ID	Comp ID			
0A	03	EVPD weak vacuum test	0 - 63.999 in H2O	0000 - FFFF
0A	05	EVPD .040" leak test	0 - 63.999 in H2O	0000 - FFFF
0A	06	EVPD .020" leak test	0 - 63.999 in H2O	0000 - FFFF
0A	42	EVAP Excess Vacuum Test	0 - 31.999 in H2O	0000 - FFFF
0A	48	EVPD purge vacuum fail test	0 - 31.999 in H2O	0000 - FFFF
	footnote:			
	bit 7:			
	Most significant bit indicates type of test limit, v			
	0 - test limit is maximum value - test fails if te			
	1 - test limit is minimum value - test fails if te	st value is less than this value		
	If the test result should be within a range of val	ues two messages will be returned		
	one with the maximum value and one with the			
	bit 6 - bit 0			
	bit 6 - bit 0 Component ID - manufacturer defined - nece	essary when multiple components or		